Protected Power MOSFET

2.6 A, 52 V, N-Channel, Logic Level, Clamped MOSFET w/ ESD Protection in a SOT-223 Package

Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

Features

- Diode Clamp Between Gate and Source
- ESD Protection HBM 5000 V
- Active Over-Voltage Gate to Drain Clamp
- Scalable to Lower or Higher R_{DS(on)}
- Internal Series Gate Resistance
- Pb-Free Packages are Available

Applications

Automotive and Industrial Markets:
 Solenoid Drivers, Lamp Drivers, Small Motor Drivers

MAXIMUM RATINGS (T, I = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	V _{DSS}	52-59	V
Gate-to-Source Voltage - Continuous	V _{GS}	±15	V
Drain Current - Continuous @ T _A = 25°C - Single Pulse (t _p = 10 μs) (Note 1)	I _D	2.6 10	А
Total Power Dissipation @ T _A = 25°C (Note 1)	P _D	1.69	W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 50 V, $I_{D(pk)}$ = 1.17 A, V_{GS} = 10 V, L = 160 mH, R_{G} = 25 Ω)	E _{AS}	110	mJ
Thermal Resistance, Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	$R_{ heta JA} \ R_{ heta JA}$	74 169	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

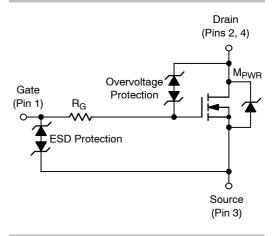
- 1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in²).
- When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in²).



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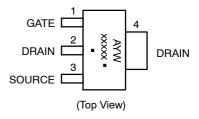
V _{DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX
52 V	107 m Ω	2.6 A





SOT-223 CASE 318E STYLE 3

MARKING DIAGRAM



A = Assembly Location

Y = Year W = Work Week xxxxx = F9N05 or 9N05A

= Pb-Free Package(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Charac	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 3) $ \begin{array}{c} (V_{GS}=0 \ V, \ I_D=1.0 \ mA, \ T_J=25^\circ C) \\ (V_{GS}=0 \ V, \ I_D=1.0 \ mA, \ T_J=-40^\circ C \ to \ 125^\circ C) \\ \end{array} $ Temperature Coefficient (Negative)		V _{(BR)DSS}	52 50.8	55 54 –9.3	59 59.5	V V mV/°C
Zero Gate Voltage Drain Current (V _{DS} = 40 V, V _{GS} = 0 V) (V _{DS} = 40 V, V _{GS} = 0 V, T _J = 125°C)		I _{DSS}			10 25	μΑ
Gate-Body Leakage Current $(V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V})$ $(V_{GS} = \pm 14 \text{ V}, V_{DS} = 0 \text{ V})$		I _{GSS}		±22	±10	μΑ
ON CHARACTERISTICS (Note 3)	•		•	•	•	
Gate Threshold Voltage (Note 3) $(V_{DS} = V_{GS}, I_D = 100 \ \mu\text{A})$ Threshold Temperature Coefficient (Negative)		V _{GS(th)}	1.3	1.75 -4.1	2.5	V mV/°C
Static Drain-to-Source On-Resistance (Note 3)		R _{DS(on)}		190 165 107	380 200 125	mΩ
Forward Transconductance (Note 3) (V	_{OS} = 15 V, I _D = 2.6 A)	9FS		3.8		Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}		155	250	pF
Output Capacitance	$V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 10 \text{ kHz}$	C _{oss}		60	100	
Transfer Capacitance		C _{rss}		25	40	
Input Capacitance				170		pF
Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 10 kHz	C _{oss}		70		
Transfer Capacitance		C _{rss}		30		

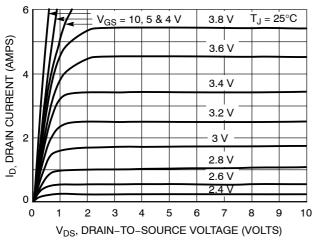
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

MOSFET ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Charac	Symbol	Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (No	te 4)					
Turn-On Delay Time		t _{d(on)}		275	465	ns
Rise Time	V _{GS} = 4.5 V, V _{DD} = 40 V,	t _r		1418	2400	
Turn-Off Delay Time	$I_D = 2.6 \text{ A}, R_D = 15.4 \Omega$	t _{d(off)}		780	1320	
Fall Time		t _f		1120	1900	
Turn-On Delay Time		t _{d(on)}		242		ns
Rise Time	$V_{GS} = 4.5 \text{ V}, V_{DD} = 40 \text{ V},$	t _r		1165		
Turn-Off Delay Time	$I_D = 1.0 \text{ A}, R_D = 40 \Omega$	t _{d(off)}		906		
Fall Time		t _f		1273		
Turn-On Delay Time		t _{d(on)}		107		ns
Rise Time	V _{GS} = 10 V, V _{DD} = 15 V,	t _r		290		
Turn-Off Delay Time	$I_D = 2.6 \text{ A}, R_D = 5.8 \Omega$	t _{d(off)}		1540		
Fall Time		t _f		1000		
Gate Charge		Q _T		4.5	7.0	nC
	$V_{GS} = 4.5 \text{ V}, V_{DS} = 40 \text{ V},$ $I_{D} = 2.6 \text{ A (Note 3)}$	Q ₁		0.9		
	.5(Q ₂		2.6		
Gate Charge		Q _T		3.9		nC
	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 1.5 A (Note 3)	Q ₁		1.0		
		Q ₂		1.7		
SOURCE-DRAIN DIODE CHARACTE	RISTICS					
Forward On-Voltage	$I_S = 2.6 \text{ A}, V_{GS} = 0 \text{ V (Note 3)}$ $I_S = 2.6 \text{ A}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C}$	V _{SD}		0.81 0.66	1.5	V
Reverse Recovery Time		t _{rr}		730		ns
	$I_S = 1.5 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_S/dt = 100 \text{ A/}\mu\text{s} \text{ (Note 3)}$	t _a		200		
		t _b		530		
Reverse Recovery Stored Charge		Q _{RR}		6.3		μC
ESD CHARACTERISTICS						
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	5000			V
	Machine Model (MM)	1	500			

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

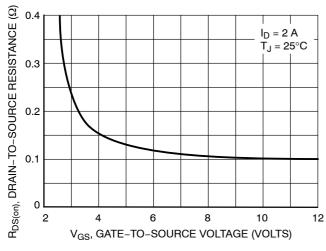
TYPICAL PERFORMANCE CURVES



 $V_{DS} \ge 10 \text{ V}$ ID, DRAIN CURRENT (AMPS) 3 $T_J = -55^{\circ}C$ $T_J = 25^{\circ}C$ = 100°C 0 2 6 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



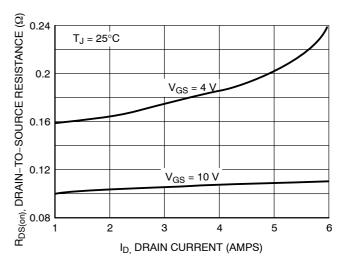
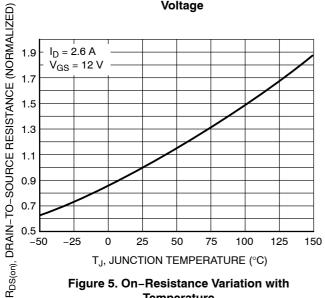


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**



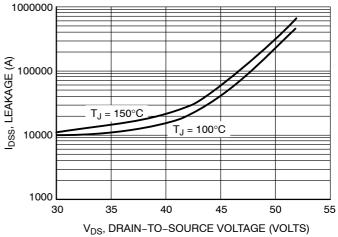
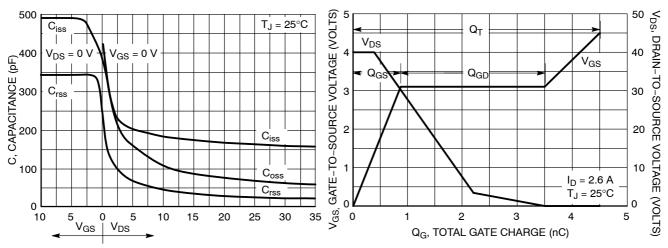


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total
Gate Charge

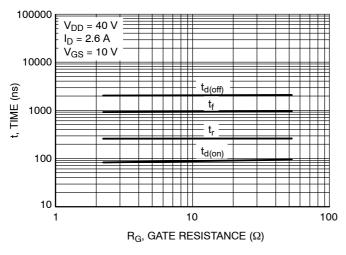


Figure 9. Resistance Switching Time Variation vs. Gate Resistance

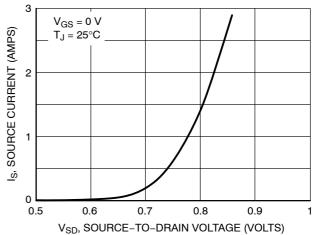


Figure 10. Diode Forward Voltage vs. Current

ORDERING INFORMATION

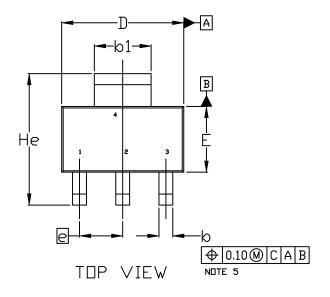
Device	Package	Shipping [†]
NIF9N05CLT1	SOT-223	
NIF9N05CLT1G	SOT-223	1000 / Tape & Reel
NIF9N05ACLT1G	(Pb-Free)	
NIF9N05CLT3	SOT-223	
NIF9N05CLT3G	SOT-223	4000 / Tape & Reel
NIF9N05ACLT3G	(Pb-Free)	

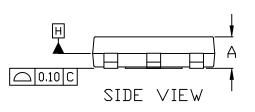
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

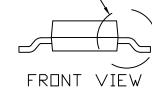


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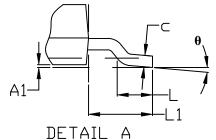
DATE 02 OCT 2018







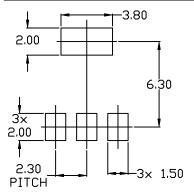
SEE DETAIL A



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
 MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. ALLIS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
Ø	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
U	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
е		2,30 BSC	,	
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0°		10°	



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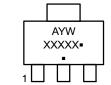
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DATE 02 OCT 2018

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

GENERIC MARKING DIAGRAM*



A = Assembly Location

Y = Year W = Work Week

 $XXXXX \ = Specific \ Device \ Code$

= Pb-Free Package

(Note: Microdot may be in either location)
*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "•", may
or may not be present. Some products may
not follow the Generic Marking.

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